



# **Phase Control Thyristor**

**Target Information** 

DS5499-1.2 February 2002

#### **FEATURES**

- Double Side Cooling
- High Surge Capability
- Low Inductance Internal Construction

### **APPLICATIONS**

- High Power Converters
- DC Motor Control
- High Voltage Power Supplies

### **VOLTAGE RATINGS**

| Part and Ordering<br>Number | Repetitive Peak<br>Voltages<br>V <sub>DRM</sub> and V <sub>DRM</sub><br>V | Conditions  |
|-----------------------------|---|---|
| DCR1660Y65                  | 6500  | $T_{vi} = 0^{\circ} \text{ to } 125^{\circ}\text{C},$ |
| DCR1660Y64                  | 6400  | $I_{DRM} = I_{RRM} = 150 \text{mA},$                  |
| DCR1660Y63                  | 6300  | $V_{DRM}$ , $V_{RRM}$ $t_p = 10ms$ ,                  |
| DCR1660Y62                  | 6200  | V <sub>DSM</sub> & V <sub>RSM</sub> =                 |
| DCR1660Y61                  | 6100  | V <sub>DRM</sub> & V <sub>RRM</sub> + 100V            |
| DCR1660Y60                  | 6000  | respectively  |

Lower voltage grades available.

# **ORDERING INFORMATION**

When ordering, select the required part number shown in the Voltage Ratings selection table.

For example:

#### DCR1660Y63

Note: Please use the complete part number when ordering and quote this number in any future correspondance relating to your order.

#### **KEY PARAMETERS**

| $V_{DRM}$                  |       | 6500V                   |
|----------------------------|-------|-------------------------|
| I <sub>T(AV)</sub>         |       | 1665A                   |
| I <sub>rem</sub>           | (max) | 28000A                  |
| I_ <sub>TSM</sub><br>dV/dt | . ,   | <b>1000V/</b> μs        |
| dl/dt                      |       | <b>300Α/</b> μ <b>s</b> |

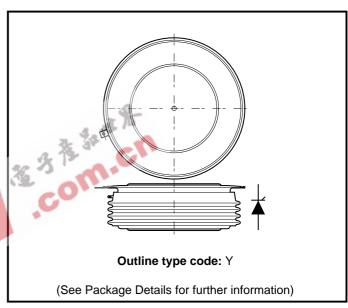


Fig. 1 Package outline



# **CURRENT RATINGS**

# $T_{case} = 60$ °C unless stated otherwise.

| Symbol              | Parameter                            | Test Conditions          |      | Units |  |  |  |  |
|---------------------|--------------------------------------|--------------------------|------|-------|--|--|--|--|
| Double Side         | Double Side Cooled                   |                          |      |       |  |  |  |  |
| I <sub>T(AV)</sub>  | Mean on-state current                | Half wave resistive load | 1665 | Α     |  |  |  |  |
| I <sub>T(RMS)</sub> | RMS value                            | -                        | 2600 | Α     |  |  |  |  |
| I <sub>T</sub>      | Continuous (direct) on-state current | -                        | 2478 | Α     |  |  |  |  |
| Single Side         | Single Side Cooled                   |                          |      |       |  |  |  |  |
| I <sub>T(AV)</sub>  | Mean on-state current                | Half wave resistive load | 1112 | А     |  |  |  |  |
| I <sub>T(RMS)</sub> | RMS value                            | -                        | 1746 | А     |  |  |  |  |
| I <sub>T</sub>      | Continuous (direct) on-state current | · a_                     | 1556 | А     |  |  |  |  |

# $T_{case} = 80^{\circ}C$ unless stated otherwise.

| Symbol              | Parameter                            | Test Conditions          | Max. | Units |  |  |  |
|---------------------|--------------------------------------|--------------------------|------|-------|--|--|--|
| Double Sid          | Double Side Cooled                   |                          |      |       |  |  |  |
| I <sub>T(AV)</sub>  | Mean on-state current                | Half wave resistive load | 1323 | А     |  |  |  |
| I <sub>T(RMS)</sub> | RMS value                            | -                        | 2077 | А     |  |  |  |
| I <sub>T</sub>      | Continuous (direct) on-state current | -                        | 1944 | А     |  |  |  |
| Single Side         | e Cooled                             |                          | •    |       |  |  |  |
| I <sub>T(AV)</sub>  | Mean on-state current                | Half wave resistive load | 876  | А     |  |  |  |
| I <sub>T(RMS)</sub> | RMS value                            | -                        | 1376 | А     |  |  |  |
| I <sub>T</sub>      | Continuous (direct) on-state current | -                        | 1196 | А     |  |  |  |



# **SURGE RATINGS**

| Symbol           | Parameter                               | Test Conditions                                  | Max.                   | Units            |
|------------------|---|--|------------------------|------------------|
| I <sub>TSM</sub> | Surge (non-repetitive) on-state current | 10ms half sine, T <sub>case</sub> = 125°C        | 22.0                   | kA               |
| l²t              | I <sup>2</sup> t for fusing             | V <sub>R</sub> = 50% V <sub>RRM</sub> - 1/4 sine | 2.4 x 10 <sup>6</sup>  | A <sup>2</sup> s |
| I <sub>TSM</sub> | Surge (non-repetitive) on-state current | 10ms half sine, T <sub>case</sub> = 125°C        | 28.0                   | kA               |
| l²t              | I <sup>2</sup> t for fusing             | V <sub>R</sub> = 0                               | 3.92 x 10 <sup>6</sup> | A <sup>2</sup> s |

# **DYNAMIC CHARACTERISTICS**

| Symbol                             | Parameter                                     | Test Conditions   | Min. | Max. | Units |
|------------------------------------|---|---|------|------|-------|
| I <sub>RRM</sub> /I <sub>RRM</sub> | Peak reverse and off-state current            | At V <sub>RRM</sub> /V <sub>DRM</sub> , T <sub>case</sub> = 125°C   | -    | 300  | mA    |
| dV/dt                              | Max. linear rate of rise of off-state voltage | To 67% V <sub>DRM</sub> , T <sub>j</sub> = 125°C  | -    | 1000 | V/μs  |
| dl/dt                              | Rate of rise of on-state current              | From 67% V <sub>DRM</sub> , Repetitive 50Hz   | -    | 150  | A/μs  |
|                                    |   | Gate source 30V, 15 $\Omega$ , Non-repetitive $t_{r} \leq 0.5 \mu s, T_{j} = 125 ^{\circ} C$  | -    | 300  | A/μs  |
| V <sub>T(TO)</sub>                 | Threshold voltage                             | At T <sub>vj</sub> = 125°C  | -    | 1.2  | V     |
| r <sub>T</sub>                     | On-state slope resistance                     | At T <sub>vj</sub> = 125°C  | -    | 0.61 | mΩ    |
| t <sub>gd</sub>                    | Delay time                                    | $V_D = 67\% V_{DRM}$ , gate source 30V, 15Ω<br>$t_r = 0.5 \mu s$ , $T_j = 25 ^{\circ} C$  | 0.5  | 1.5  | μs    |
| t <sub>q</sub>                     | Turn-off time                                 | $I_{T} = 1000A$ , $t_{p} = 1$ ms, $T_{j} = 125$ °C,<br>$V_{R} = 100V$ , $dI_{RR}/dt = 10A/\mu$ s,<br>$V_{DR} = 67\% V_{DRM}$ ,<br>$dV_{DR}/dt = 25V/\mu$ s linear | 1500 | -    | μs    |
| I <sub>L</sub>                     | Latching current                              | $T_j = 25^{\circ}C, V_D = 10V$  | -    | 600  | mA    |
| I <sub>H</sub>                     | Holding current                               | $T_j = 25^{\circ}C, V_{G-K} = \infty$   | -    | 200  | mA    |



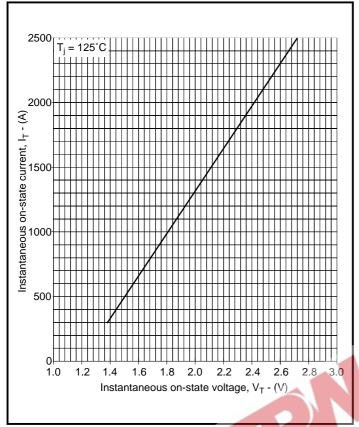
# THERMAL AND MECHANICAL RATINGS

| Symbol               | Parameter                             | Test Conditio            | ns          | Min. | Max.   | Units |
|----------------------|---------------------------------------|--------------------------|-------------|------|--------|-------|
| R <sub>th(j-c)</sub> | Thermal resistance - junction to case | Double side cooled       | DC          | -    | 0.0095 | °CW   |
|                      |                                       | Single side cooled       | Anode DC    | -    | 0.019  | °CW   |
|                      |                                       |                          | Cathode DC  | -    | 0.019  | °CW   |
| $R_{\text{th(c-h)}}$ | Thermal resistance - case to heatsink | Clamping force 50kN      | Double side | -    | 0.002  | °CW   |
|                      |                                       | (with mounting compound) | Single side | -    | 0.004  | °CW   |
| $T_{v_{j}}$          | Virtual junction temperature          | On-state (conducting)    |             | -    | 135    | °C    |
|                      |                                       | Reverse (blocking)       |             | -    | 125    | °C    |
| $T_{stg}$            | Storage temperature range             |                          |             | -55  | 125    | °C    |
| F <sub>m</sub>       | Clamping force                        | - A-                     |             | 45.0 | 55.0   | kN    |

| F <sub>m</sub>   | Clamping force                | JE 165  | 45.0 | 55.0 | kN    |
|------------------|-------------------------------|---|------|------|-------|
| ATE TRI          | GGER CHARACTERISTICS AND RATI | NGS & BANGO                                   |      |      |       |
| Symbol           | Parameter                     | Test Conditions                               | М    | ax.  | Units |
| $V_{GT}$         | Gate trigger voltage          | $V_{DRM} = 5V$ , $T_{case} = 25^{\circ}C$     | 3    | 3.0  | V     |
| l <sub>GT</sub>  | Gate trigger current          | $V_{DRM} = 5V$ , $T_{case} = 25^{\circ}C$     | 3    | 00   | mA    |
| $V_{\rm GD}$     | Gate non-trigger voltage      | At V <sub>DRM</sub> T <sub>case</sub> = 125°C |      | .25  | V     |
| $V_{FGM}$        | Peak forward gate voltage     | Anode positive with respect to cathode        |      | 30   | V     |
| $V_{FGN}$        | Peak forward gate voltage     | Anode negative with respect to cathode        |      | .25  | V     |
| $V_{RGM}$        | Peak reverse gate voltage     | -   | :    | 5    | V     |
| I <sub>FGM</sub> | Peak forward gate current     | Anode positive with respect to cathode        | 1    | 10   | Α     |
| $P_GM$           | Peak gate power               | See table fig. 4                              | 1    | 50   | W     |
| $P_{G(AV)}$      | Mean gate power               | -   |      | 5    | W     |



# **CURVES**



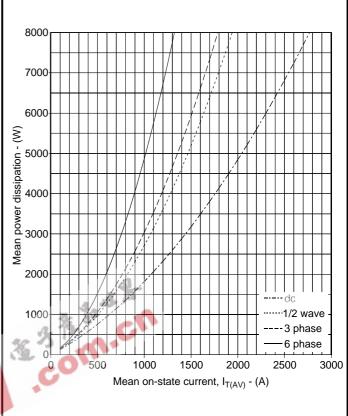


Fig.2 Maximum (limit) on-state characteristics

Fig.3 Power dissipation



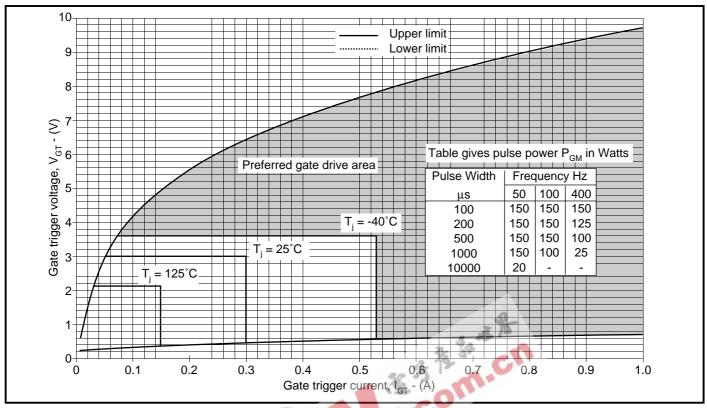


Fig.4 Gate characteristics

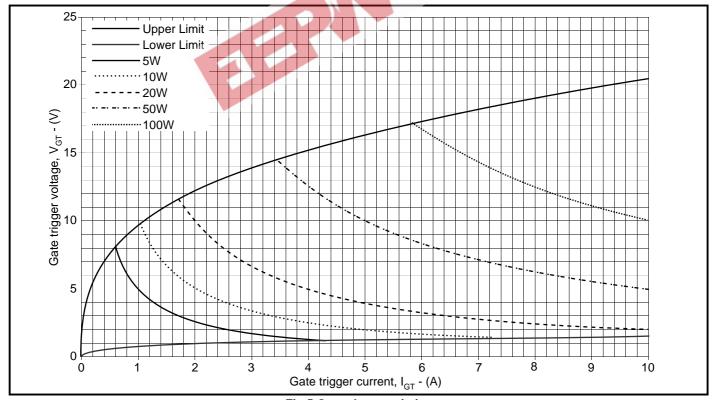
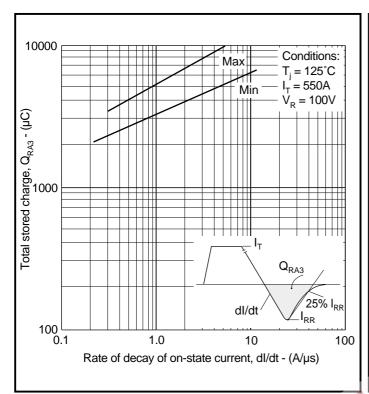


Fig.5 Gate characteristics





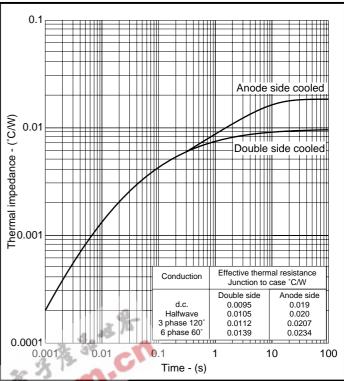
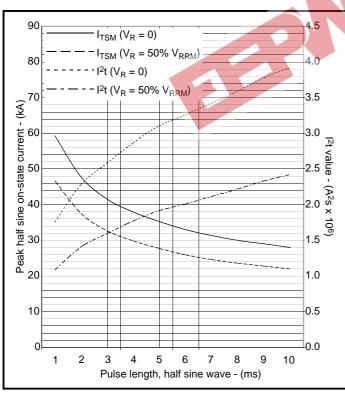
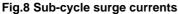


Fig.6 Stored charge

Fig.7 Maximum (limit) transient thermal impedance - junction to case (°C/W)





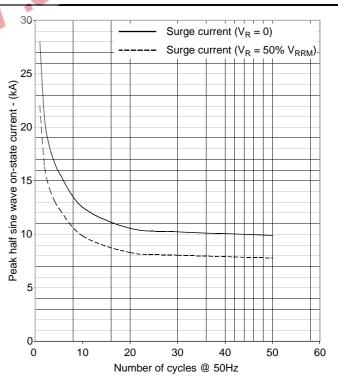
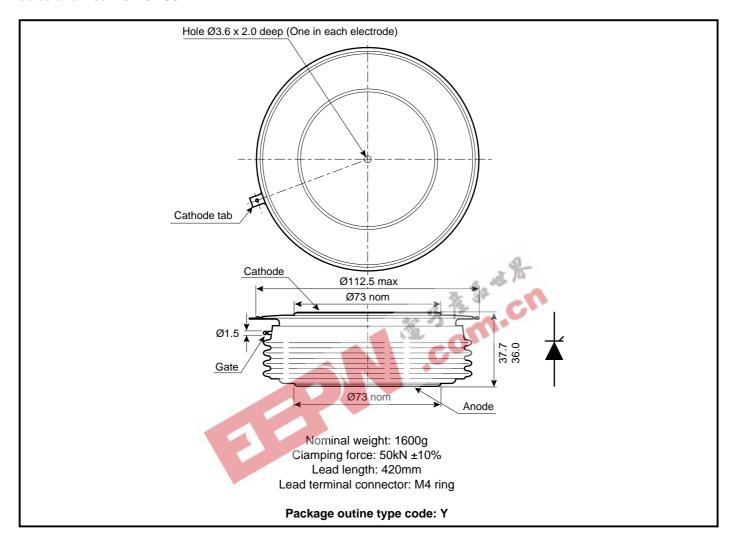


Fig.9 Multi-cycle surge currents



### **PACKAGE DETAILS**

For further package information, please visit our website or contact your nearest Customer Service Centre. All dimensions in mm, unless stated otherwise. DO NOT SCALE.





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The Power Assembly group was set up to provide a support service for those customers requiring more than the basic semiconductor, and has developed a flexible range of heatsink and clamping systems in line with advances in device voltages and current capability of our semiconductors.

We offer an extensive range of air and liquid cooled assemblies covering the full range of circuit designs in general use today. The Assembly group continues to offer high quality engineering support dedicated to designing new units to satisfy the growing needs of our

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Disc devices require the correct clamping force to ensure their safe operation. The PACS range includes a varied selection of pre-loaded clamps to suit all of our manufactured devices. Types available include cube clamps for single side cooling of 'T' 23mm and 'E' 30mm discs, and bar clamps right up to 83kN for our 'Z' 100mm thyristors and diodes.

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Please refer to our application note on device clamping, AN4839

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The Power Assembly group has its own proprietary range of extruded aluminium heatsinks. They have been designed to optimise the performance of Dynex semiconductors. Data with respect to air natural, forced air and liquid cooling (with flow rates) is available on 50 request.

please contact your nearest sales representative or customer For further information on device clamps, heatsinks and assemblies, service office.



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